

BUK545-50A-VB Datasheet N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a			
60	0.024 at V _{GS} = 10 V	50			
	0.028 at V _{GS} = 4.5 V	40			

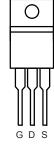
FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Surface Mount
- Available in Tape and Reel
- Dynamic dV/dt Rating
- Logic-Level Gate Drive
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC



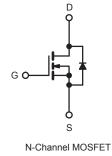
RoHS'

COMPLIANT



TO-220AB

Top View



PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	60	V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current ^f	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$		I	50		
Continuous Drain Current	VGSALIOV	T _C = 100 °C	I _D	36	А	
Pulsed Drain Current ^a			I _{DM}	200		
Linear Derating Factor				1.0	W/°C	
Linear Derating Factor (PCB Mount) ^e				0.025		
Single Pulse Avalanche Energy ^b			E _{AS}	400	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$			P	150	w	
Maximum Power Dissipation (PCB Mount) ^e	T _A = 25 °C		P _D –	3.7	~ ~ ~ ~	
Peak Diode Recovery dV/dt ^c	dV/dt	4.5	V/ns			
Operating Junction and Storage Temperature Range			T _J , T _{stg} - 55 to + 175			
Soldering Recommendations (Peak Temperature) ^d	for 10 s		300 ^d			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, $L = 179 \text{ }\mu\text{H}$, $R_g = 25 \Omega$, $I_{AS} = 51 \text{ A}$ (see fig. 12). c. $I_{SD} \le 51 \text{ A}$, dl/dt $\le 250 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

e. When mounted on 1" square PCB (FR-4 or G-10 material).

f. Current limited by the package, (die current = 51 A).

d. 1.6 mm from case.

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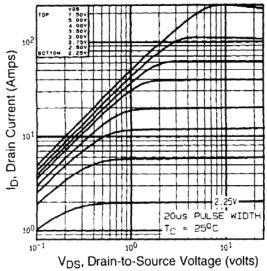


THERMAL RESISTANCE RATI	SYMBOL	ТҮР		MAX.			LINUT		
PARAMETER		IYP	•	62		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	-	-						
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	- 40			°C/W				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 1.0							
ote		1							
. When mounted on 1" square PCB (FR-4 o		,							
SPECIFICATIONS (T _J = 25 °C, u		ise noted)			1	1 1		T	
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNI	
Static		1			T	-		-	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 25	50 µA	60	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, $I_D = 1 \text{ mA}$		$I_D = 1 \text{ mA}$	-	0.070	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		1.0	-	2.5			
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 10 V$		-	-	± 100	nA		
Zero Gate Voltage Drain Current	1	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25		
	IDSS	V _{DS} = 48 V,	$V_{GS} = 0 V,$	$T_J = 150 \ ^\circ C$	-	-	250	μA	
	_	V _{GS} = 10 V	۱ _D	= 21 A ^b	-	0.024	-		
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 4.5 V	١ _D	= 15 A ^b	-	0.028	-	Ω	
Forward Transconductance	g _{fs}	V _{DS} = 25 V, I _D = 21A ^b		23	-	-	S		
Dynamic						<u> </u>			
Input Capacitance	C _{iss}		-	190		pF			
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	920		-		
Reverse Transfer Capacitance	C _{rss}			_	170		-		
Total Gate Charge	Qg	$V_{GS} = 5.0 \text{ V}$ $I_{D} = 51 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 ^b			-	-	66	<u> </u>	
Gate-Source Charge	Q _{gs}			-	-	12	nC		
Gate-Drain Charge	Q _{gd}			_	_	43			
Turn-On Delay Time	t _{d(on)}	V _{DD} = 30 V, I _D = 51 A,		_	17	_	-		
Rise Time	t _r			_	230	_			
Turn-Off Delay Time	t _{d(off)}	V_{DD} $R_q = 4.6 \Omega,$	$= 30 \text{ v}, \text{ I}_{\text{D}} =$ $\text{R}_{\text{D}} = 0.56 \Omega$	2, see fig. 10 ^b	_	2	-	ns	
Fall Time	t _f			_	110	_	-		
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	Ls			-	7.5	-			
Drain-Source Body Diode Characteristic	s			8	I			I	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	50 ^c	- A		
Pulsed Diode Forward Current ^a	I _{SM}			-	-	200			
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 51 A, V _{GS} = 0 V ^b		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = 51 \text{ A}, dl/dt = 100 \text{ A}/\mu\text{s}^{b}$ Intrinsic turn-on time is negligible (turn		-	130	180	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.84	1.3	μC		
Forward Turn-On Time	t _{on}			l on in dor			<u> </u>		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
b. Pulse width ≤ 300 µs; duty cycle ≤ 2 %.
c. Current limited by the package, (Die Current = 51 A).



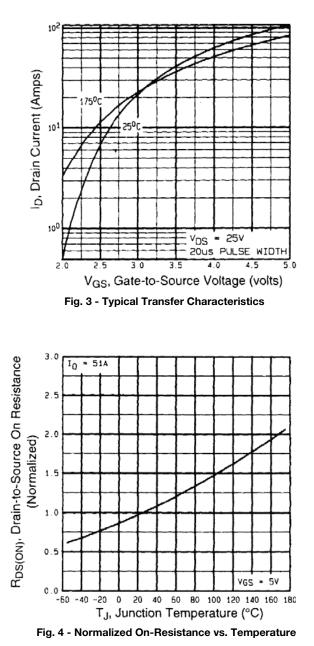


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Fig. 2 - Typical Output Characteristics, T_C = 150 °C





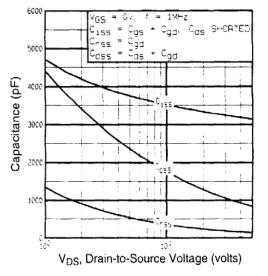


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

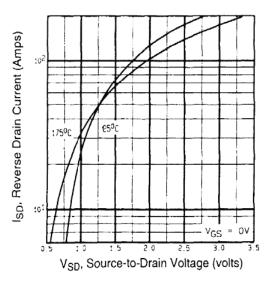
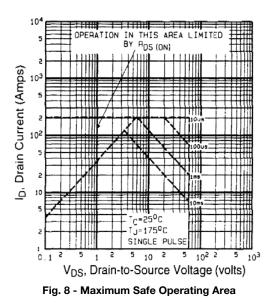


Fig. 7 - Typical Source-Drain Diode Forward Voltage



Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage





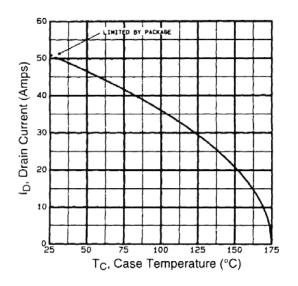


Fig. 9 - Maximum Drain Current vs. Case Temperature

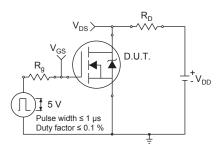


Fig. 10a - Switching Time Test Circuit

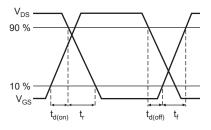


Fig. 10b - Switching Time Waveforms

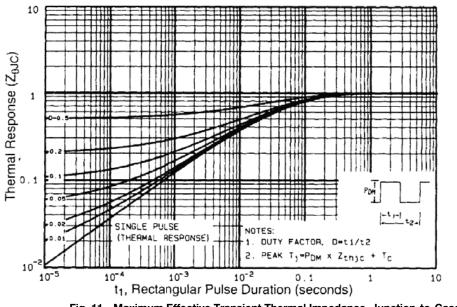


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



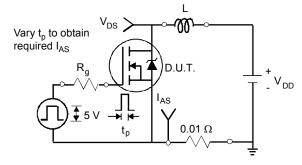


Fig. 12a - Unclamped Inductive Test Circuit

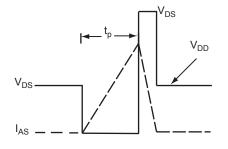


Fig. 12b - Unclamped Inductive Waveforms

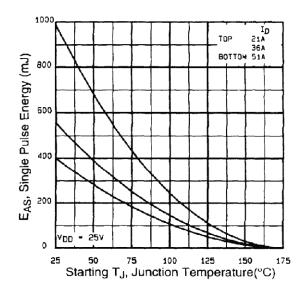


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

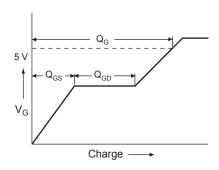


Fig. 13a - Basic Gate Charge Waveform

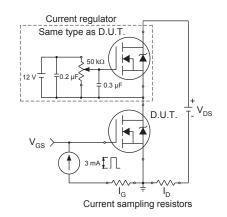
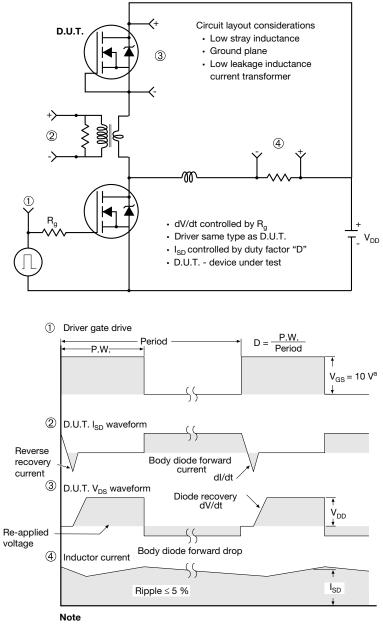


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

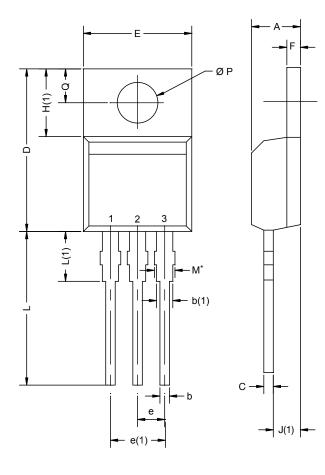


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



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	MILLIN	IETERS	INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
А	4.25	4.65	0.167	0.183
b	0.69	1.01	0.027	0.040
b(1)	1.20	1.73	0.047	0.068
С	0.36	0.61	0.014	0.024
D	14.85	15.49	0.585	0.610
Е	10.04	10.51	0.395	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.09	6.48	0.240	0.255
J(1)	2.41	2.92	0.095	0.115
L	13.35	14.02	0.526	0.552
L(1)	3.32	3.82	0.131	0.150
ØΡ	3.54	3.94	0.139	0.155
Q	2.60	3.00	0.102	0.118
ECN: X12-0 DWG: 5471	0208-Rev. N,	08-Oct-12		

Notes

* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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